

<b>Notice of References Cited</b>	Application/Control No. 10/733,763	Applicant(s)/Patent Under Reexamination KIRN ET AL.	
	Examiner X L. Bautista	Art Unit 2179	Page 1 of 1



**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,029,191	02-2000	Kurashima, Akihisa	709/205
*	B	US-6,263,505 B1	07-2001	Walker et al.	725/110
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	2003/0078969 A1, Sprague et al, 4/24/2003.
	V	2005/0210395 A1, Wakita et al, 9/22/2005.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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